

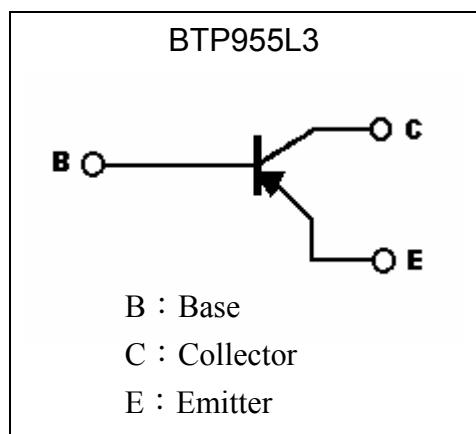
PNP Epitaxial Planar High Current (High Performance) Transistor

BTP955L3

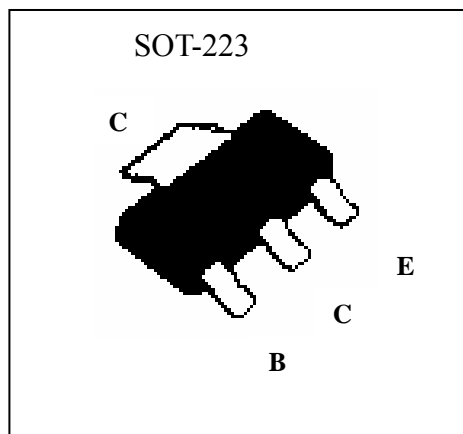
Features

- 4 Amps continuous current, up to 10 Amps peak current
- Very low saturation voltage
- Excellent gain characteristics specified up to 3 Amps
- Ptot=3Watts
- Extremely low equivalent on resistance, $R_{CE(SAT)}=90m\Omega$ at 3A
- Pb-free lead plating and halogen-free package

Symbol

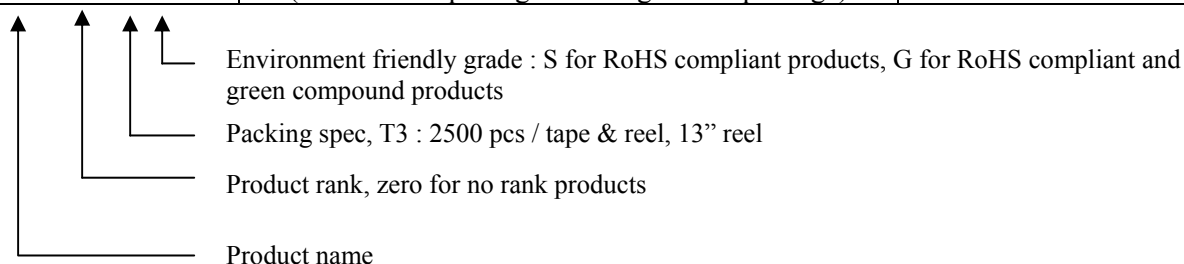


Outline



Ordering Information

Device	Package	Shipping
BTP955L3-X-T3-G	SOT-223 (Pb-free lead plating and halogen-free package)	2500 pcs / tape & reel





Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Collector-Base Voltage	V _{CB0}	-180	V
Collector-Emitter Voltage	V _{CEO}	-140	V
Emitter-Base Voltage	V _{EBO}	-6	V
Continuous Collector Current	I _C	-4	A
Peak Collector Current	I _{CP}	-10	A
Base Current	I _B	-1	A
Power Dissipation @T _A =25°C	P _d	3 (Note 1)	W
ESD susceptibility		4000 (Note 2)	V
Operating and Storage Temperature Range	T _j ; T _{stg}	-55 ~ +150	°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{θJC}	12.5	°C/W
Thermal Resistance, Junction-to-ambient, max	R _{θJA}	41 (Note 1)	°C/W

Note: 1.The power which can be dissipated assuming the device is mounted in a typical manner on a P.C.B. with copper equal to 4 square inch minimum.

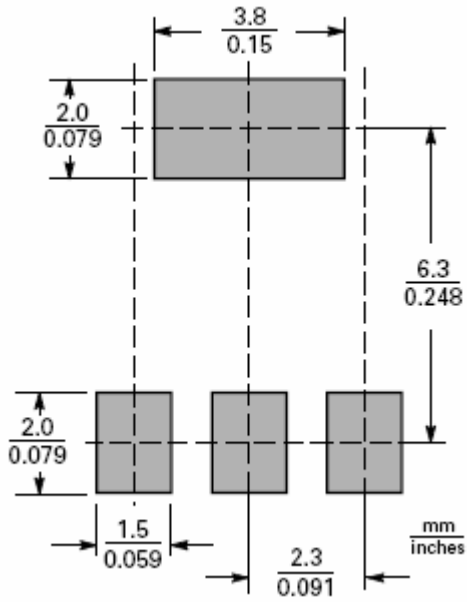
2.Human body model, 1.5kΩ in series with 100pF

Characteristics (Ta=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
BV _{CB0}	-180	-210	-	V	I _C =-100μA
BV _{CER}	-180	-210	-	V	I _C =-1μA, R _{BE} ≤1kΩ
*BV _{CEO}	-140	-170	-	V	I _C =-10mA
BV _{EBO}	-6	-8	-	V	I _E =-100μA
IC _{B0}	-	-	-50	nA	V _{CB} =-150V
IC _{ER}	-	-	-50	nA	V _{CE} =-150V, R _{BE} ≤1kΩ
IE _{B0}	-	-	-10	nA	V _{EB} =-6V
*V _{CE(sat)1}	-	-40	-60	mV	I _C =-100mA, I _B =-5mA
*V _{CE(sat)2}	-	-70	-120	mV	I _C =-500mA, I _B =-50mA
*V _{CE(sat)3}	-	-110	-150	mV	I _C =-1A, I _B =-100mA
*V _{CE(sat)4}	-	-270	-370	mV	I _C =-3A, I _B =-300mA
*V _{BE(sat)}	-	-930	-1110	mV	I _C =-3A, I _B =-300mA
*V _{BE(on)}	-	-830	-950	mV	V _{CE} =-5V, I _C =-3A
h _{FE1}	100	200	-	-	V _{CE} =-5V, I _C =-10mA
h _{FE2}	100	200	300	-	V _{CE} =-5V, I _C =-1A
*h _{FE3}	75	140	-	-	V _{CE} =-5V, I _C =-3A
*h _{FE4}	-	10	-	-	V _{CE} =-5V, I _C =-10A
f _T	-	110	-	MHz	V _{CE} =-10V, I _C =-100mA, f=50MHz
C _{ob}	-	40	-	pF	V _{CB} =-20V, f=1MHz
ton		68		ns	I _C =-1A, I _{B1} =-100mA, I _{B2} =100mA,
toff		1030		ns	V _{CC} =-50V

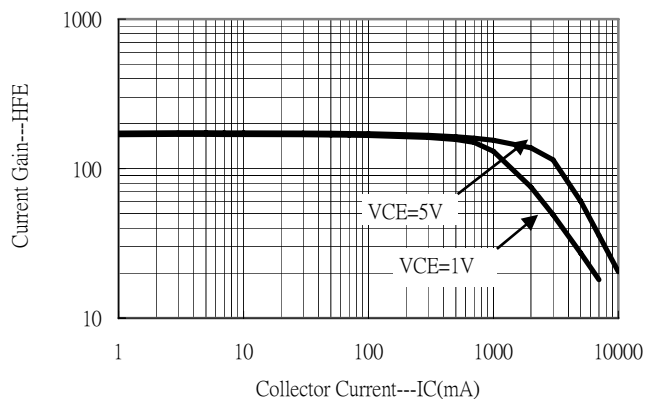
*Pulse Test: Pulse Width ≤380μs, Duty Cycles≤2%

Recommended soldering footprint

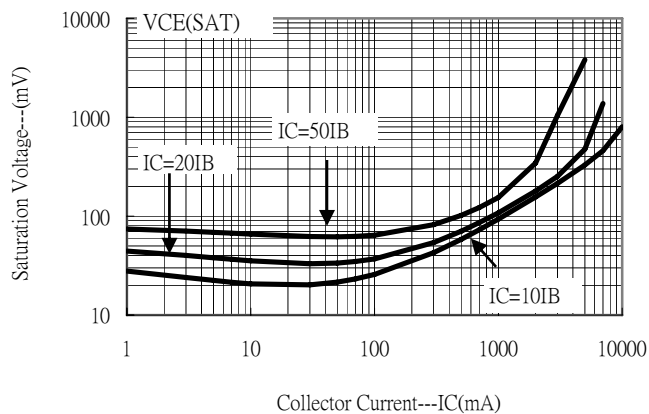


Typical Characteristics

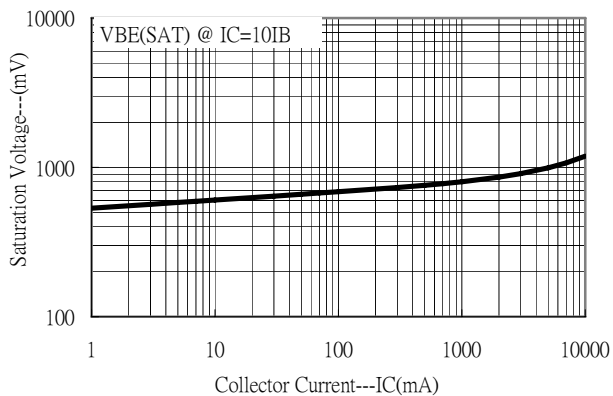
Current Gain vs Collector Current



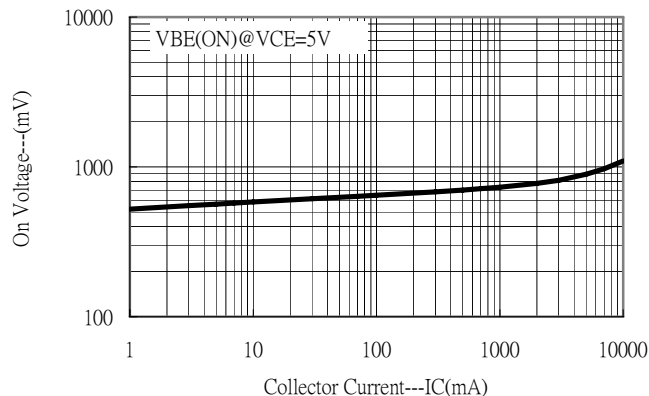
Saturation Voltage vs Collector Current



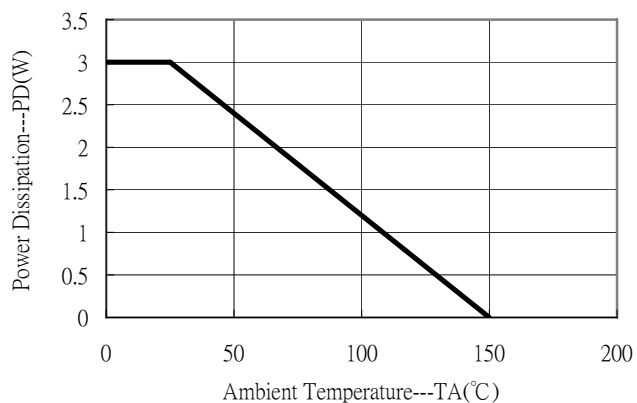
Saturation Voltage vs Collector Current



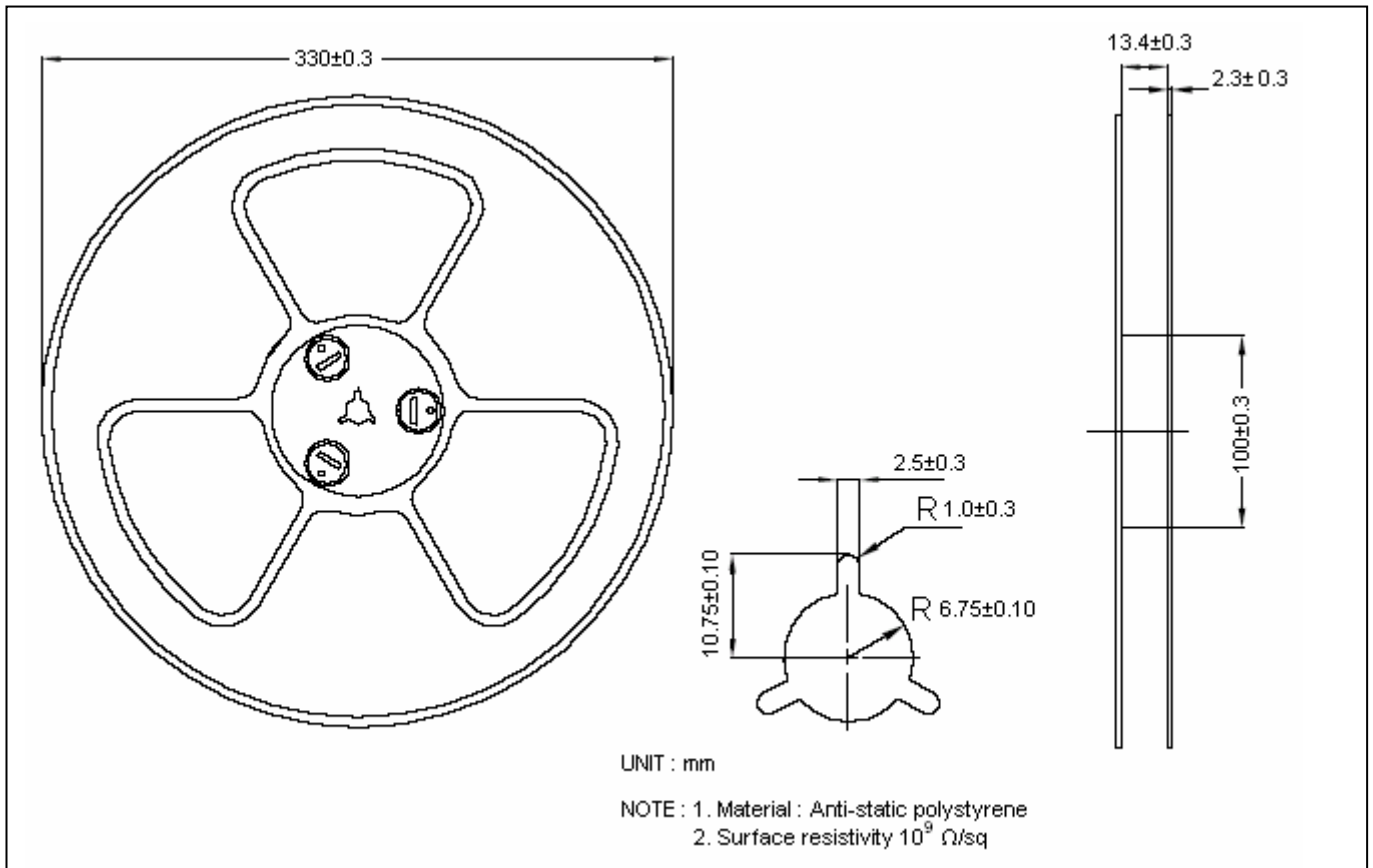
On Voltage vs Collector Current



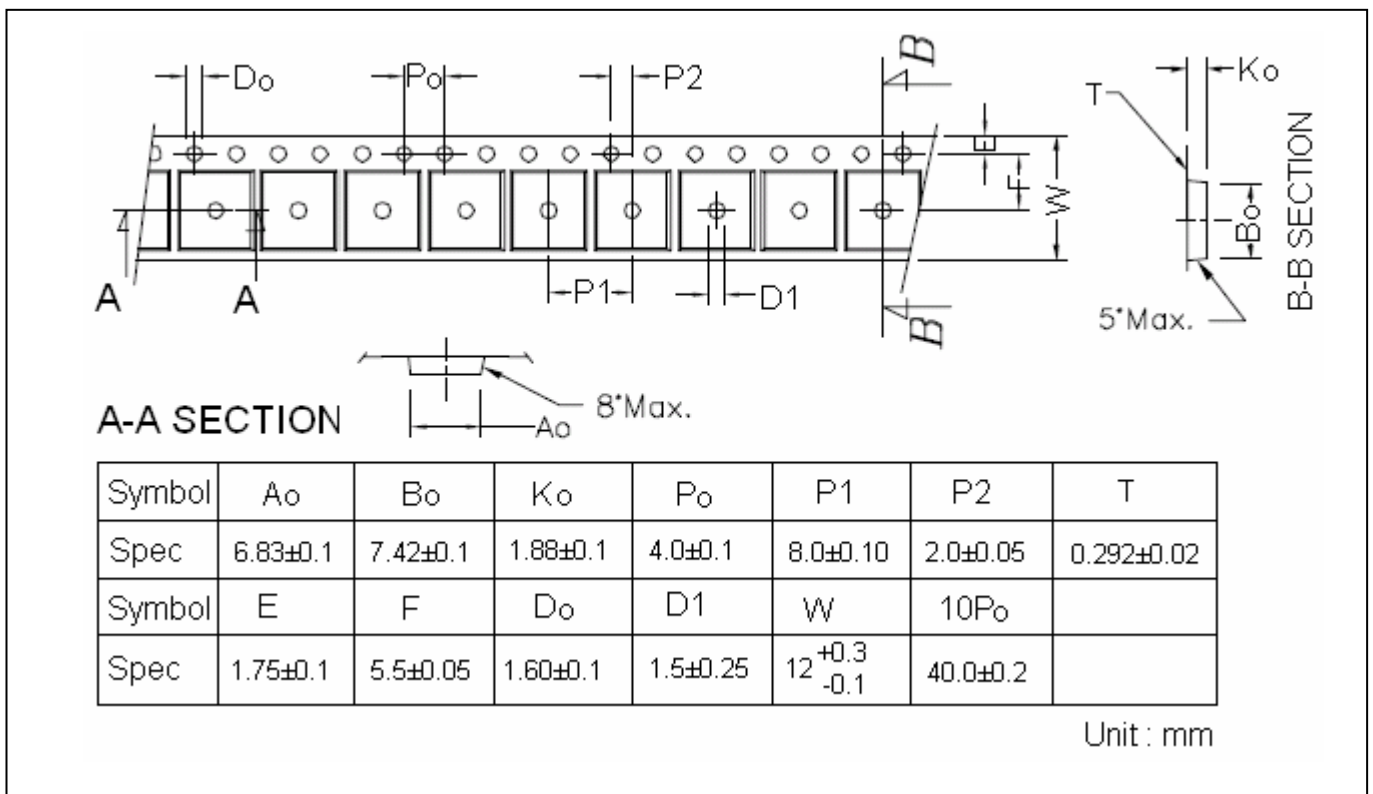
Power Derating Curve



Reel Dimension



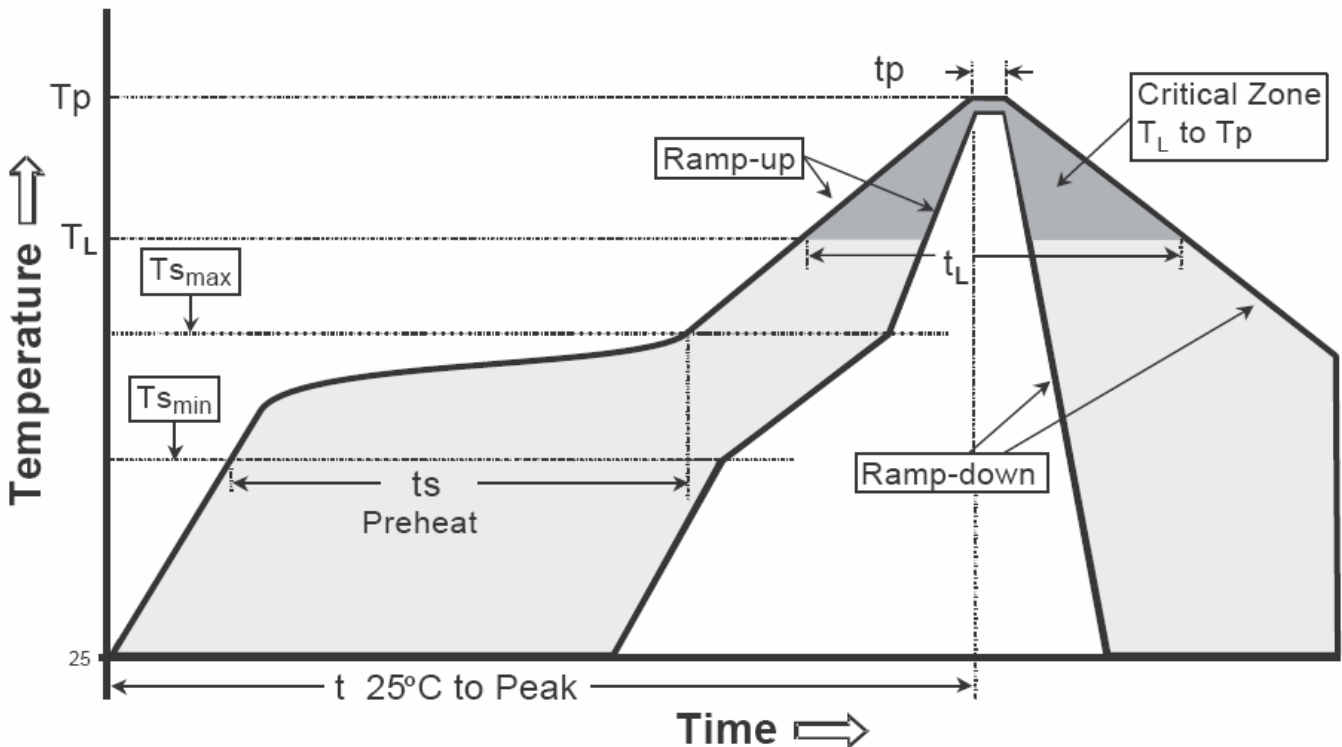
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

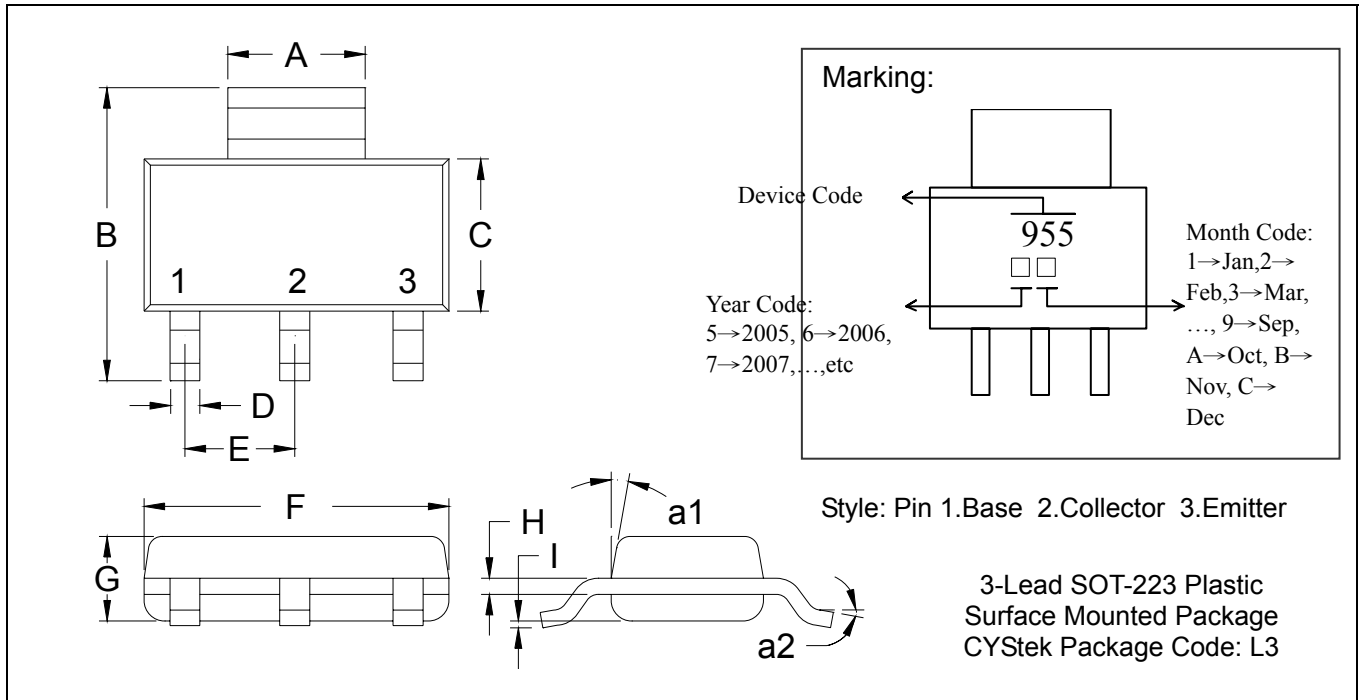
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-223 Dimension



*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1142	0.1220	2.90	3.10	G	0.0551	0.0709	1.40	1.80
B	0.2638	0.2874	6.70	7.30	H	0.0098	0.0138	0.25	0.35
C	0.1299	0.1457	3.30	3.70	I	0.0008	0.0039	0.02	0.10
D	0.0236	0.0315	0.60	0.80	a1	*13°	-	*13°	-
E	*0.0906	-	*2.30	-	a2	0°	10°	0°	10°
F	0.2480	0.2638	6.30	6.70					

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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